Notice of References Cited Application/Control No. 10/591,745 Examiner YEWEBDAR T. TADESSE Applicant(s)/Patent Under Reexamination IGARASHI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,820,673	10-1998	Sentilles et al.	118/319
*	В	US-6,416,307	07-2002	Buazza et al.	425/143
*	С	US-6,296,707	10-2001	Adamczyk et al.	118/668
*	D	US-2007/0065633	03-2007	Mori et al.	428/137
	Е	US-			
	F	US-			
	O	US-			
	Ι	US-		1	
	_	US-			
	7	US-			
	K	US-			
	Ш	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
6	R					
	s					
	I				100	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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